

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination IDEHARA, TAKENORI	
		Examiner Satwant K. Singh	Art Unit 2626	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-2002/0054330	05-2002	Jinbo et al.	358/1.15
	B	US-	.		
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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